

Notice of References Cited

Application/Control No.

10/790,728

Applicant(s)/Patent Under
Reexamination
HAN, CHEUL KYUNG

Examiner

LINH T. NGUYEN

Art Unit

2627

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0036861	02-2003	Matsumoto, Keishi	702/60
*	B	US-2003/0043711	03-2003	Mashimo et al.	369/47.39
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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